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| Notice of References Cited | Application/Control No. 10/718,022 | Applicant(s)/Patent Under Reexamination HUMPHRIES ET AL. | |
| | Examiner Raymond W. Addie | Art Unit 3671 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| | A | US-4,228,867 | 10-1980 | Wirt, Leslie S. | 181/210 |
| | B | US-4,838,524 | 06-1989 | McKeown et al. | 256/24 |
| | C | US-5,588,786 | 12-1996 | House et al. | 405/285 |
| | D | US-5,942,736 | 08-1999 | Cortonesi, Rivo | 181/289 |
| | E | US-5,984,044 | 11-1999 | Christensen, Arthur E. | 181/210 |
| | F | US-6,016,887 | 01-2000 | Underhill et al. | 181/210 |
| | G | US-6,190,085 B1 | 02-2001 | Johansson, Jerzy Kryszof | 404/6 |
| | H | US-6,669,402 B1 | 12-2003 | Davis et al. | 404/6 |
| | I | US-6,718,672 B1 | 04-2004 | Wieringa, Lawrence D. | 40/612 |
| | J | US-6,926,461 B1 | 08-2005 | Faller et al. | 404/6 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|-------------|----------------|----------------|
| | N | NL 1024629 | 10-2003 | Netherlands | de Regt, A. D. | E01F8/02 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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